

<b>Notice of References Cited</b>	Application/Control No. 10/531,666		Applicant(s)/Patent Under Reexamination TSUKAHARA ET AL.	
	Examiner Chau N. Nguyen		Art Unit 2831	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,524,921	08-1970	WOLF LEO	174/70C
*	B	US-2003/0178221	09-2003	Chiu et al.	174/117.00F
*	C	US-3,168,617	02-1965	RICHTER HERMAN W	174/117FF
*	D	US-3,408,453	10-1968	SHELTON JR CHARLES F	174/258
*	E	US-4,616,717	10-1986	Luetzow, Edwin J.	174/117F
*	F	US-4,626,298	12-1986	Allard, Ira L.	156/55
*	G	US-4,460,804	07-1984	Svejkovsky, Roger L.	174/117A
*	H	US-4,251,712	02-1981	Parr, David	219/203
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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